

PAVLOV, P.V.; LEONOVA, A.G.

Stabilization of diphtherial toxin for the Schick test. Zhur.  
mikrobiol. epid. i immun. 29 no. 3: 106-111 Mr '58. (NIRA 11:4)

1. Iz Instituta epidemiologii i mikrobiologii imeni Gamalei AMN SSSR.  
(DIPHTHERIA, immunology,  
Schick test, stabilization of toxin (Rus))

PAVLOV, P.V., AKIMOVA, V.V., PEMYANKEVICH, A.N.

Purified adsorbed scarlet fever toxin. Report No.2: Adsorption of  
purified scarlet fever toxin. Zhur. mikrobiol. epid. i immun.  
29 no.9:8-10 S'58 (MIRA 11:10)

1. Iz Instituta epidemiologii i mikrobiologii imeni Gamalei AMN SSSR.  
(STREPTOCOCCUS,  
scarlatinae, toxin purification (Rus))

PAVLOV, P.V., NITEL'MAN, S.L., AKIMOVA, V.V.

Purified adsorbed scarlet fever toxin. Report No.3:Result of active immunization against scarlet fever with purified adsorbed scarlet fever toxin. Zhur.mikrobiol. epid. i immun. 29 no.9:11-15 S '58 (MIRA 11:10)

1. Iz Instituta epidemiologii i mikrobiologii imeni Gamalei AMN SSSR.

(SCARLET FEVER, prev. & control,  
vacc. with purified adsorbed toxin (Rus))

PAVLOV, P. V.; MITEL'MAN, V. L.; ANIMOVA, V. V.

"Problems of active immunization against scarlet."  
fever

Report submitted at the 13th All-Union Congress of Hygienists,  
Epidemiologists and Infectionists. 1959

ZHDANOV, V.M., red.; VASHKOV, V.I., red.; ZAKHAROVA, M.S., red.;  
KUDLAY, D.G., red.; PAVLOV, P.V., red.; RUDNEV, G.P., red.  
(Moskva); TIMAKOV, V.D., red. (Moskva); TROITSKIY, V.L., red.;  
KHRISTOV, L.N., red. (Moskva); NECHAYEV, S.V., red.;  
HEL'CHIKOVA, Yu.S., tekhn.red.

[Transactions of the All-Union Conference of Hygienists, Epidemio-  
logists, Microbiologists, and Infections Disease Specialists]  
Doklady XIII Vsesoiuznogo s"ezda gigenistov, epidemiologov, mikro-  
biologov i infektsionistov. Pod red. V.M.Zhdanova. Moskva, Gos.  
izd-vo med.lit-ry Medgiz. Vol.2. [Section on epidemiology, micro-  
biology, infectious diseases, and the organization of the public  
health system] Otdelenie epidemiologii, mikrobiologii, infektsion-  
nykh boleznei i organizatsii zdravookhraneniia. Pod red. V.I.  
Vashkova. 1959. 866 p. (MIRA 14:1)

1. Vsesoyuznyy s"yezd gigenistov, epidemiologov, mikrobiologov  
i infektsionistov. 13th.  
(EPIDEMIOLOGY--CONGRESSES)

PAVLOV, P.V.; AKINOVA, V.V.; APANASHCHENKO, N.I.; ATSEROVA, I.S.

Experimental studies on antigenic and immunogenic properties of combined vaccines against scarlet fever, diphtheria, and whooping cough. Zhur.mikrobiol.epid. i immun. 30 no.5:42-48 My '59. (MIRA 12:9)

1. Iz Instituta epidemiologii i mikrobiologii imeni Gamalei AN SSSR.

(VACCINES AND VACCINATION,  
scarlet fever-diphtheria-whooping cough  
vaccine, animal tests (Rus))  
(SCARLET FEVER, immunol.  
same)  
(WHOOPIING COUGH immunol.  
same)  
(DIPHTHERIA, immunol.  
same)

LEONOVA, A.G.; PAVLOV, P.V.

Use of the method of precipitation in agar in the selection of  
toxigenic variants of strain PWS; author's abstract. Zhur.  
mikrobiol.epid. i immun. 30 no.5:88-89 My '59. (MIRA 12:9)

1. Iz Instituta epidemiologii i mikrobiologii imeni Gamalei  
AN SSSR.

(DIPHTHERIA)

STEPANCHENOK-RUDNIK, G.I.; NEKHOTENOVA, Ye.I.; BLAGOVESHCHENSKIY, V.A.;  
PAVLOV, P.V.

Effect of ultrasonic waves on diphtheria toxin; author's abstract.  
Zhur.mikrobiol.,epid.i immun. 30 no.11:118-119 N '59. (MIRA 13:3)  
(DIPHTHERIA) (TOXINS AND ANTITOXINS)  
(ULTRASONIC WAVES--PHYSIOLOGICAL EFFECT)



PAVLOV, P.V.; AKIMOVA, V.V.

Precipitation in gel with scarlet fever toxin. Zhur. mikrobiol.  
epid. i immun. 31 no. 10:39-44 0 '60. (MIRA 13:12)

1. Iz Otdela profilaktiki detskikh infektsiy Instituta epidemiologii  
i mikrobiologii imeni Gamalei AMN SSSR.  
(SCARLET FEVER)

PAVLOV, P.V.; LEONOVA, A.G.

Determination of the optimal antigen dose for active immunization.  
Report No.1: Determination of the optimal dose of native diphtherial  
anatoxin. Zhur. mikrobiol., epid. i immun. 32 no.9:8-12 S '61.  
(MIRA 15:2)

1. Iz Instituta epidemiologii i mikrobiologii imeni Gamalei AMN SSSR.  
(DIPHTHERIA) (TOXINS AND ANTITOXINS)

PAVLOV, P.V.; LEONOVA, A.G.

Effect of the products of protein splitting in a culture medium on toxin formation. Report No.2: Antigenic and immunogenic properties of diphtheria toxins (toxoids) obtained on a medium, digested by two enzymes, during culture of the Weisensee strain. Zhur.mikrobiol.epid.i immun. 32 no.1:95-99 Ja '61. (MIRA 14:6)

1. Institutu epidemiologii i mikrobiologii imeni Gamalei AMN SSSR.  
(CORNEBACTERIUM DIPHtherIAE) (TOXINS AND ANTITOXINS)  
(TRYPSIN) (PROTEINASE)

SOKOLOV, Mikhail Ignat'yevich; ~~PAVLOV, Petr Vasil'yevich;~~ PETERSON, O.P.,  
red.; BALDINA, N.F., tekhn. red.

[Manual on the use of vaccines and sera] Spravochnik po primene-  
niyu vaktsin i syvorotok. Moskva, Medgiz, 1961. 162 p.  
(MIRA 15:2)

(VACCINATION—HANDBOOKS, MANUALS, ETC.)

PAVLOV, P.V.; NEKHOTENOVA, Ye.I.; LEONOVA, A.G.; APANASHCHENKO, N.I.;  
FOFYANKEVICH, A.N.

Production of diphtheria toxin under conditions of submerged cul-  
tures. Nauch. osn. proizv. bakt. prep. 10:71-76 '61. (MIRA 18:7)

1. Institut epidemiologii i mikrobiologii im. Gamalei AMN SSSR.

PAVLOV, P.V.; MITEL'MAN, S.L.; AKIMOVA, V.V.

Preparations for active immunization against scarlet fever. Nauch.  
osn. proizv. bakt. prep. 10:129-134 '61. (MIRA 18:7)

1. Institut epidemiologii i mikrobiologii im. Gamalei AMN SSSR.

PAVLOV, Petr Vasil'yevich; USPENSKIY, V.I., red.; PRONINA, N.D.,  
tekh. red.

[Active immunization against scarlet fever] Aktivnaia im-  
munizatsiia protiv skarlatiny. Moskva, Medgiz, 1963. 217 p  
(MIRA 16:9)

(SCARLET FEVER--PREVENTIVE INOCULATION)

PAVLOV, P.V.; LEONOVA, A.G.

Determination of optimum doses of antigens used for active immunization. Report No.2: Determination of the optimum dose of sorbed diphtheria anatoxin as a monoantigen and as a component included in polyvalent preparations. Zhur. mikrobiol., epid. i immun. 40 no.3:59-63 Mr '63.

(MIRA 17:2)

1. Iz Instituta epidemiologii i mikrobiologii imeni Gamalei AMN SSSR.



MUROMTSEV, S.N., prof., av. red. [deceased]; ANAN'IN, V.V., prof., red.; VYGODCHIKOV, G.V., prof., red.; ZIL'BER, L.A., prof., red.; MILENUSHKIN, Yu.I., kand. biol. nauk, red.; FAYLOV, I.V., prof., red.; TROITSKIY, V.L., prof., red. [deceased]; SHEVTSOV, D.G., red.; GRACHEVA, N.P., kand. med. nauk, red.

[Problems of infectious pathology and the experimental therapy of infections (on the 60th birthday of Professor Kh.Kh. Flanel'es, Corresponding Member of the Academy of Medical Sciences of the U.S.S.R.); transactions of the Institute] Voprosy infektsionnoi patologii i eksperimental'noi terapii infektsii (k 60-letliu so dnya rozhdeniia chlena-korr. AMN SSSR prof. Kh.Kh. Flanel'esa); trudy instituta. Pod obshchei red. S.N. Muromtseva. Moskva, 1963. 495 p. (MIRA 17:7)

1. Akademiya meditsinskikh nauk SSSR, Moscow. Institut epidemiologii i mikrobiologii. 2. Deystvitel'nyy chlen Vsesoyuznogo nauchnogo obshchestva sotsial'no-ekonomicheskikh nauk imeni V.I.Lenina, direktor Instituta epidemiologii i mikrobiologii im. N.F.Gamalei AMN SSSR (for Muromtsev). 3. Deystvitel'nyy chlen AMN SSSR (for Zil'ber, Vygodchikov, Troitskiy).

PAVLOV, P.V.; AKIMOVA, V.V.; LEONOVA, A.G.; KASHINSEVA, N.S.

Experimental study of combined vaccine for active immunization  
against scarlet fever, diphtheria, whooping cough and tetanus.  
Zhur. mikrobiol., epid. i immun. 40 no.9:3-10 S'63. (MIRA 1975

1. Iz Instituta epidemiologii i mikrobiologii imeni Gamalei  
AMN SSSR.

S/126/63/015/001/014/029  
E111/E383

AUTHORS: Paylov, P.V. and Uskov, V.A.

TITLE: Possibility of using the gamma-spectrum method for investigating processes of the simultaneous diffusion of two components

PERIODICAL: Fizika metallov i metallovedeniye, v. 15, no. 1, 1963, 105 - 108

TEXT: Simultaneous diffusion of several elements is involved in semiconductor developments. To obtain the necessary experimental data by the method entailing the removal of successive layers and use of radioactive isotopes it is necessary to register separately the various, simultaneously-diffusing elements. This was achieved in the present work by using a single-crystal scintillation gamma-spectrometer. The apparatus was calibrated with a series of radioactive elements and then checked with mixtures of the radioactive isotopes Cs<sup>137</sup> and Fe<sup>59</sup>. Values for the diffusion coefficients of Fe<sup>59</sup> in an Fe-1.16 at.% Mo-0.93 at.% C alloy at 950, 1050 and 1150 °C obtained by this method agreed well with those yielded by Card 1/2

Possibility of using ....

S/126/63/015/001/014/029  
E111/E383

the Geiger-Muller counter method. There are 3 figures and  
1 table.

ASSOCIATION: Gor'kovskiy fiziko-tekhnicheskij institut  
(Gor'kiy Physicotechnical Institute)

SUBMITTED: June 8, 1962



Card 2/2

*Photo, P. 11*

*3*

Crystal structure of hercynite, datolite and gadolinite.  
 J. L. Taylor and M. B. Berman. *Journal of Metamorphic Geology*, 1983, 1, 2, 1-10.  
 The crystal structures of hercynite, datolite and gadolinite were determined from X-ray diffraction data. The structure of hercynite was determined by a complete Patterson function method based on the absence of the  $h$  and  $k$  axes in the Patterson function. The monoclinic unit cell has the dimensions  $a = 10.14$  Å,  $b = 7.89$  Å,  $c = 4.86$  Å;  $\beta = 90^\circ$ ; space group  $C2/c$ . The atomic positions are:  $Si_1$  in  $x = 0.000$ ,  $y = 0.200$ ,  $z = 0.000$ ;  $Si_2$  (or  $Si_3$ ) in  $x = 0.333$ ,  $y = 0.498$ ,  $z = 0.5597$ ;  $O_1$  in  $x = 0.0411$ ,  $y = 0.397$ ,  $z = 0.370$ ;  $O_2$  in  $x = 0.439$ ,  $y = 0.278$ ,  $z = 0.650$ ;  $O_3$  in  $x = 0.105$ ,  $y = 0.140$ ,  $z = 0.6754$ ;  $O_4$  in  $x = 0.141$ ,  $y = 0.111$ ,  $z = 0.341$ . The  $Ca-O$  bond lengths are 2.32, 2.37, 2.43 Å. The  $Si-O$  bond lengths are 1.60, 1.64, 1.67 Å. The  $Ca-O$  bond lengths are 2.52 to 2.73 Å. The  $Ca-O$  bond lengths are 2.46 to 2.70 Å. For datolite (with  $a = 9.02$  Å,  $b = 7.60$  Å,  $c = 4.84$  Å,  $\beta = 90^\circ$ , space group  $C2/c$ ), the previous structure determined by the trial method (C.A. 47, 73701) was improved. Gadolinite, somewhat disturbed by metamictization, shows  $a = 9.87$  Å,  $b = 7.59$  Å,  $c = 4.65$  Å,  $\beta = 99^\circ 33'$ ,  $Z = 2$ . Because of the uncertainty of the atomic factor  $f$  for  $Y$ , the reliability coefficient is less satisfactory than for hercynite and datolite.  
 W. Ruedi.

SOV/70-3-1-17/26

AUTHORS: Borisov, S.V., Pavlov, P.V. and Belov, N.V.

TITLE: A Graphical Method for Solving the Fundamental Harker-Kasper Inequalities (Graficheskiy metod resheniya osnovnykh neravenstv Kharkera-Kaspera)

PERIODICAL: Kristallografiya, 1958, Vol 3, Nr 1, pp 90-92 (USSR)

ABSTRACT: The most powerful inequality relating the absolute unitary structure amplitudes is:

$$(U_H \pm U_K)^2 \leq (1 \pm U_{H+K})(1 \pm U_{H-K}) .$$

This leads to a relationship between the signs of  $S_{H+K} = S_H \cdot S_K$  and  $S_{H-K} = S_H \cdot S_K$ . The examination of all quartets of reflections is a long process and can be facilitated by suitable graphs. If  $(U_H \pm U_K)$  is denoted by  $\Sigma$  and  $(1 \pm U_{H+K})$  and  $(1 \pm U_{H-K})$  by  $x$  and  $y$ , respectively, then the inequality is  $\Sigma^2 \leq xy$  which takes the form of hyperbolae for the case of equivalence. Lines of constant  $\Sigma$  are drawn out on two graphs (each with  $U_{H-K}$  as abscissae and  $U_{H+K}$  as ordinates) one with values of  $\Sigma$  greater than 1 and

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SOV/70-3-1-17/26

A Graphical Method for Solving the Fundamental Harker-Kasper Inequalities

the other with values less than 1. The graphs are then divided into four regions: a) where  $S_{H-K} = S_H \cdot S_K$  obtains; b) where  $S_{H+K} = S_H \cdot S_K$  obtains; c) where neither obtains and ab) where both are true. These can be overlaid with weighted reciprocal nets. It can be seen that the most effective inequalities will be obtained when three of the amplitudes selected are large and the fourth small. For values of  $\sum$  near to 1 the inequalities will also be effective, for a pair  $U_{H+K}$  and  $U_{H-K}$  of the order of 0.15 to 0.20. There are 3 figures and 7 references, 5 of which are Soviet and 2 English.

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SOV/70-3-1-17/26  
A Graphical Method for Solving the Fundamental Harker-Kasper  
Inequalities

ASSOCIATION: Institut kristallografii AN SSSR  
(Institute of Crystallography of the Ac.Sc.USSR)

SUBMITTED: November 25, 1957

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SOV/70-4-3-8/32

**AUTHORS:** Pavlov, P.V. and Belov, N.V.

**TITLE:** The Determination of the Structures of Herderite, Datolite and Gadolinite by Direct Methods

**PERIODICAL:** Kristallografiya, 1959, Vol 4, Nr 3, pp 324 - 340 (USSR)

**ABSTRACT:** The structures of these three compounds were determined in parallel by direct methods, particularly by those elaborated in the Institute of Crystallography and in Gor'kiy University, which proved to be exceptionally powerful. A full account is given for pedagogic purposes. The cell dimensions and space group, found by Strunz, for herderite<sub>5</sub> ( $a = 9.80$ ,  $b = 7.68$ ,  $c = 4.80 \text{ \AA}$ ,  $\beta = 90^{\circ}06'$ ,  $C_{2h} = P2_1/a$ ) were confirmed.  $d_{\text{obs.}} = 3.00$  and  $Z = 4$ , the formula unit being  $\text{CaBePO}_4\text{F}$ . The use of Harker-Kasper inequalities followed by Zachariasen's statistical analysis has been successful several times before and was applied here. Weissenberg photographs with Mo radiation provided abundant data. There were 167 independent  $hk0$  reflexions. Amplitudes were put on an absolute scale by Wilson and Vaynshteyn's methods.

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SOV/70-4-3-8/32

The Determination of the Structures of Herderite, Datolite and Gadolinite by Direct Methods

There were 15 with  $|U_{hk0}| > 0.5$ . In all, 45 confirmed sign relationships of the form  $S_{H+K} = S_H \cdot S_K$  were found. 18 signs were found uniquely by:

$$|U_{hk\ell}|^2 \leq 1/2 + 1/2 U_{2h, 2k, 2\ell}$$

and other inequalities and less directly others giving a total of 56 "banker" reflexions. Two signs were given arbitrarily. Zachariasen's method was then applied and gave another 84 signs, i.e. a total of 140 out of 167, > 70%. About 20-24 pairs determined each sign. The resulting Fourier projection showed all atoms and calculated F values gave R = 24% only two having signs opposite to those assumed. A second synthesis with the remaining 27 reflexions and recalculation with the new positions gave R = 14.9% without zeros and 20.4% with zeros up to  $\sin \theta/\lambda = 1.1$ . Normalisation by  $\sum F_o = \sum F_c$  showed that the

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SOV/70-4-3-8/32

## The Determination of the Structures of Herderite, Datolite and Gadolinite by Direct Methods

original setting of the amplitudes on an absolute scale was accurate to within 5%. The  $h0l$  projection was treated similarly. There were 116 non-zero reflexions, 21 with  $|U_{h0l}| \geq 0.5$ . Without zeros  $R = 14.3\%$  and with 60 zeros up to 1.1  $R = 19.7\%$ . Vaynshteyn's method gave the probable errors in atomic positions as follows: for Ca 0.004 Å; P - 0.006 Å; Be - 0.033 Å, O - 0.015 Å and F - 0.013 Å. Table 1 gives the atomic co-ordinates in the structures of herderite, datolite and gadolinite (in hundredths of a, b and c). Datolite I represents Japanese data and datolite II Pavlov and Belov's.

The structure consists of infinite pseudotetragonal nets of  $PO_4$  and  $BeO_3F$  tetrahedra. In the net the fourfold centrosymmetrical rings of tetrahedra of two sorts alternate with locked centrosymmetrical pulled-out octagons of the same tetrahedra. This is characteristic of feldspars and other related aluminosilicates. The

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SOV/70-4-3-8/52

## The Determination of the Structures of Herderite, Datolite and Gadolinite by Direct Methods

structure has two storeys, the lower consisting of 4 antiprisms (with 8 corners) around the Ca atoms and the upper of linked  $\text{PO}_4$  tetrahedra in one orientation and  $\text{BeO}_3\text{F}$  tetrahedra in another. Interatomic distances are tabulated. Pauling's valency balance does not fit very accurately for some O atoms.

$\text{CaBSiO}_4(\text{OH})$ . datolite ( $a = 9.62$ ,  $b = 7.60$ ,  $c = 4.84 \text{ \AA}$ ,  $\beta = 90^\circ$ ,  $\text{P2}_1/a$ ) was solved by Ito and Mori by a semi-heavy atom technique. The analysis reported for herderite was repeated. It was also partially repeated for gadolinite,  $\text{Fe}^{++}\text{Y}_2\text{Be}_2\text{O}_2\text{Si}_2\text{O}_8$  ( $Z = 2$ ,  $a = 9.89$ ,  $b = 7.52$ ,  $c = 4.71$ ,  $\beta = 90^\circ 33'$ ) with results given in the table. Fe atoms are found at the origins octahedrally co-ordinated but otherwise the structure is very similar to that of the other minerals.

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SOV/70-4-3-8/32  
The Determination of the Structures of Herderite, Datolite and  
Gadolinite by Direct Methods

There are 8 figures, 7 tables and 19 references. 13 of  
which are Soviet, 2 German and 4 international.

ASSOCIATION: Institut kristallografii AN SSSR (Institute of  
Crystallography of the Ac.Sc., USSR)  
Gor'kovskiy universitet im. N.I. Lobachevskogo  
(Gor'kiy University imeni N.I. Lobachevskiy)

SUBMITTED: February 23, 1959

Card 5/5

L. 13025-63 EWP(q)/EWT(m)/BDS AFFTC/ASD JD  
ACCESSION NR: AP3000629 8/0181/63/005/005/1454/1457

AUTHOR: Pavlov, P. V.; Panteleyev, V. A.

TITLE: Diffusion of antimony on the surface of germanium 27 57/55

SOURCE: Fizika tverdogo tela, (v. 5, no. 5, 1963, 1454-1457)

TOPIC TAGS: surface diffusion, body diffusion, Ge, Sb, specific resistance, semiconductor, oxide layer, SR-4, HF, hydrogen peroxide

ABSTRACT: The investigation utilizes the method proposed by Geguzin, Kovalev, and Ratner (FMM, 10, 47, 1960). Tests were made on plates of monocrystalline germanium 5 x 5 x 0.6 mm, cut normal to [111], and having a specific resistance of 30 ohm/cm. Samples were divided into three groups: one polished mechanically, a second polished chemically in standard SR-4 etchant, and the third also polished chemically, for 30 seconds in an etchant consisting of 40 parts HF, 6 parts hydrogen peroxide, and 24 parts water. Diffusion was measured in the interval 250-550C for germanium and at 350C for surfaces coated with an oxide film. The experiments show that the more carefully the surface of the semiconductor is prepared the less mobile are the atoms in the near-surface layer. The spread of Sb in the surface layer of Ge proved to be very rapid: at 100C surface diffusion

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L 13025-63

ACCESSION NR: AP3000629

took place  $10^{19}$  times as fast as body diffusion ( $10^{-13}$  sq cm/sec) as against  $10^{-32}$ ). The relative effect of the oxide film on diffusion must be explained with an allowance for some solution of the oxide as the oxide film grows. This diminishes the diffusion factor (that diffusion actually occurring in the oxide, not in the germanium itself). The authors conclude that the model used for computing parameters of "surface" diffusion at low temperatures is unacceptable. "V. M. Yermilin, a student at the Gorki State University, took part in the work." Orig. art. has: 1 figure, 1 table, and 3 formulas.

ASSOCIATION: Gor'kovskiy gos. universitet im. N. I. Lobachevskogo (Gorkiy State University)

SUBMITTED: 13Nov62

DATE ACQ: 11Jun63

ENCL: 00

SUB CODE: 00

NO REF SOV: 005

OTHER: 002

Card 2/2

ACCESSION NR: AP4013492

S/0181/64/006/002/0382/0389

AUTHORS: Pavlov, P. V.; Panteleyev, V. A.; Mayorov, A. V.

TITLE: Diffusion of antimony along dislocations in silicon

SOURCE: Fizika tverdogo tela, v. 6, no. 2, 1964, 382-389

TOPIC TAGS: impurity diffusion, antimony, dislocation, silicon, impurity concentration, boundary diffusion, body diffusion

ABSTRACT: Increase in number of dislocations in a crystal generally leads to worsening of electrical properties, but certain data indicate that dislocations may, under certain circumstances, improve some properties of actual crystals. In pursuing this possibility, the authors have solved equations for diffusion along individual tubular dislocations. The solution has been used to study the diffusion of antimony in single crystals of silicon along dislocations. Etching removed a layer from the samples on the order of 100 microns thick. This indicates that the destroyed layer was not complete. For this reason, rapid diffusion as observed in the experiments cannot be considered a surface effect. Samples were carefully selected, with uniform dislocation distribution, and this precaution eliminated the

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ACCESSION NR: AP4013492

possibility of diffusion along low-angle faces, microfractures, or other similar defects. It appears obvious that antimony has migrated through silicon along individual dislocations. Such an interpretation is confirmed by data on increased concentration of the diffusing impurities with increase in dislocation density. The activation energy of diffusion along the dislocations is substantially less than the activation energy of ordinary body diffusion (about one-fourth). This indicates an easier path of diffusion and is in agreement with the view that the dislocations are disordered zones with abundant vacancies. However, the individual dislocations must possess a lower penetration than grain boundaries, and this conforms with experimental data that prove the activation energy of diffusion along a face to be less than body diffusion (about one-third). The coefficient of diffusion along these dislocations was found to depend on temperature according to the following equation:  $D_d = 4.5 \cdot 10^2 \exp\left(-\frac{69900}{RT}\right)$  cm<sup>2</sup>/sec. Orig. art. has: 3 figures, 3 tables, and 6 formulas.

ASSOCIATION: Gor'kovskiy gosudarstvennyy universitet im. N. I. Lobachevskogo  
(Gorkiy State University)

Card 2/3

ACCESSION NR: AP4028459

S/0181/64/006/004/1231/1233

AUTHORS: Pavlov, P. V.; Panteleyev, V. A.

TITLE: A method of determining the coefficient of diffusion along the surface of a crystalline body

SOURCE: Fizika tverdogo tela, v. 6, no. 4, 1964, 1231-1233

TOPIC TAGS: diffusion coefficient, crystal, surface property, laminated sample

ABSTRACT: This is chiefly a discussion of the method of a "laminated sample" as proposed by Ya. Ye. Geguzin, G. N. Kovalov, and A. M. Ratner (FMM, 10, 47, 1960) and by Ya. Ye. Geguzin and G. N. Kovalev (FTT, 10, 1687, 1963). The present authors point out some limiting factors, defining when the method is valid. They suggest that, in investigating surface diffusion in solids by a "laminated sample," the best method of determining surface diffusion and density will be by matching the experimental concentration curve with the previously computed theoretical (standard) curve for different values of diffusion and density. In this way, the two values may be determined independently of each other for any parameter values. The authors computed (by means of an electronic computer) the theoretical concentration curves from the data in the first work cited above. The curves obviously

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ACCESSION NR: AP4028459

differ from each other, a fact that speaks favorably for the indicated method.  
Orig. art. has: 1 figure, 1 table, and 6 figures.

ASSOCIATION: Gor'kovskiy gosudarstvennyy universitet im. N. I. Lobachevskogo  
(Gorky State University)

SUBMITTED: 04Nov63

DATE ACQ: 27Apr64

ENCL: 00

SUB CODE: ME, SS

NO REF SOV: 004

OTHER: 000

Card 2/2

L 15271-65 EWT(d)/EWT(m)/EEC(k)-2/EEC-l/EWP(t)/EWP(b) Fo-l/Pq-l/Pg-l/Fk-l/  
PL-l IJP(c)/AFWL/BSL/ASD(a)-5/SSD/ASD(p)-3/AS(mp)-2/ESD(gs) JD  
ACCESSION NR: AP4048391 S/0181/64/006/011/3222/3226

AUTHOR: Pavlov, P. V.; Zorin, Ye. I.; Tetel'baum, D. I.; Popov, Yu. S. 3

TITLE: On the depth of penetration and distribution of radiation damage when germanium is bombarded with argon and nitrogen ions

SOURCE: Fizika tverdogo tela, v. 6, no. 11, 1964, 3222-3226

TOPIC TAGS: germanium, radiation defect, ion bombardment, surface layer, semiconductor material

ABSTRACT: In view of the practical interest associated with the use of ion beams in semiconductor technology, the authors measured the thickness of the inversion layers produced on n-type germanium bombarded with argon and nitrogen ions of energies of 46, 67, and 82 kev. The germanium was in the form of plates 5 x 5 x 1 mm with resistivity of 1 ohm-cm, cut perpendicular to the [111] axis. The plates were care- gm

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L 15271-65

ACCESSION NR: AP4048391

fully ground and chemically polished so that the surface was uniform within 0.2 micron. The ion bombardment was produced in an accelerator with magnetic ion separation. The samples were etched away layer by layer after irradiation and the surface resistivity was measured after each etching by a four-probe method. The results show that for argon the thickness of the inversion layer agrees well with the theory of K. O. Nielsen (Electromagnetically Enriched Isotopes and Mass Spectrometry, New York, 1956, p. 68). The thickness of the inversion layer increases with increasing energy and radiation dose, and is larger for nitrogen ions than for argon ions, although the experimental value is smaller for nitrogen than predicted by theory. The depth distributions of the specific conductivities in the inversion layers were determined and it was established that sufficiently large doses of bombarding argon ions produce on the surface of the inversion layer a high-resistance region whose thickness increases with the dose. It is suggested that this high-resistance layer is due to disordering of the crystal structure of the ger-

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L 15271-65

ACCESSION NR: AP4048391

10 #  
3

manium; this hypothesis is confirmed by electron diffraction data.  
"Students F. Frolova and S. Shul'ts of the Physics Department of  
GGU participated in the work." Orig. art. has: 4 figures, 3 formu-  
las, and 1 table.

ASSOCIATION: Gor'kovskiy gosudarstvenny\*y universitet im. N. I.  
Lobachevskogo (Gor'kiy State University)

SUBMITTED: 21Apr64

ENCL: 00

SUB CODE: SS, NP

NO REF SOV: 001

OTHER: 011

ATD PRESS: 3143

Card 3/3

L 3335-86 EWT(m)/T/ENP(t)/ENP(b)/EWA(c) IJP(c) JD

ACCESSION NR: AP5017321

UR/0181/65/007/007/2209/2211

AUTHORS: Pavlov, P. V.: Panteleyev, V. A.

TITLE: Application of the method of 'standard curves' to the investigation of the diffusion of antimony on the surface of germanium and silicon

SOURCE: Fizika tverdogo tela, v. 7, no. 7, 1965, 2209-2211

TOPIC TAGS: antimony, silicon, germanium, surface property, metal diffusion

ABSTRACT: To check whether it is possible in principle to determine separately the thickness of the surface layer in which the diffusion coefficient is larger than in the rest of the crystal, and to determine the value of the larger diffusion coefficient itself, the authors integrated the equation derived by R. T. P. Wipple (Phil. Mag. v. 45, 1225, 1954), using an electronic computer, for a wide range of the parameters encountered in practice. The result was used to investigate the diffusion of antimony over the surface of plates of p-type

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L 3335-66

ACCESSION NR: AP5017321

single-crystal silicon<sup>21</sup> (resistivity 2 ohm-cm), cut parallel to the [111] direction. Three different surface finishes were used, and the experimentally measured distribution was checked against the theoretically calculated one. The results are in good agreement with data obtained by others, but recalculation of the authors' earlier data for the diffusion of antimony over the surface of germanium (FTT v. 5, 1454, 1963), using the procedure described in this paper and a different procedure, does not give identical results. Orig. art. has: 1 figure, 1 formula, and 1 table. 4

ASSOCIATION: Gor'kovskiy gosudarstvennyy universitet im. N. I. Lobachevskogo (Gor'kiy State University) 55

SUBMITTED: 29Sep64 ENCL: 00 SUB CODE: SS

NR REF SOV: 007 OTHER: 005

Card

2/2 JP



L 26620-66 EWT(1)/EWT(m) IJP(c) JD/JG

ACC NR: AP5025369

SOURCE CODE: UR/0181/65/007/010/2940/2946

AUTHOR: Pavlov, P. V.; Zorin, Ye. I.; Tetel'baum, D. I.; Granitsyna, Z. K.

ORG: Gor'kiy State University im. N. I. Lobachevskiy (Gor'kovskiy gosudarstvennyy universitet)

TITLE: Investigation of electrical conductivity of inversion layers forming in n-type silicon during bombardment by boron ions

SOURCE: Fizika tverdogo tela, v. 7, no. 10, 1965, 2940-2946

TOPIC TAGS: electric conductivity, silicon single crystal, boron, ion bombardment

ABSTRACT: Results were presented of measuring electrical conductivity of inversion layers formed in n-type silicon as a result of bombardment of the surface by boron ions with energies of 25-150 kev. Dependence of electrical conductivity of an inversion layer, formed during boron ion bombardment, on dosage and annealing temperature has qualitatively, a similar character during all energies in the diapazone studied. The effect was studied of radiation dose, temperature and annealing time. With any dosage in the 1-1000 microcoulomb . cm<sup>-2</sup> range, a sufficiently high annealing temperature leads to an electrical conductivity

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L 26620-66

ACC NR: AP5025369

value corresponding to the quantity of boron atoms introduced. The greater the dosage, the higher the annealing temperature needed to reach this state. This possibility of developing inversion layers during bombardment without subsequent annealing was indicated. With a sufficiently large dose of boron ions the effect of injected boron atoms prevailed under the influence of radiation defects; thus the formation of p-type layer in n-silicon was possible without additional annealing. Orig. art. has: 4 figs.

SUB CODE: 20/ SUBM DATE: 03Apr65/ ORIG REF: 004/ OTH REF: 009

Card 2/2

I 15977-66 EWT(j)/EWT(m)/T/EWP(t) IJP(c) JD/AT  
 ACC NR: AP5021276 SOURCE CODE: UR/0020/65/163/005/1128/1130

AUTHOR: Pavlov, P. V.; Zorin, Ye. I.; Tetel'baum, D. I.; Popov, Yu. S. 60  
59  
B

ORG: Gorki Physicotechnical Research Institute of the Gorki State University im. N. I. Lobacheskiy (Gor'kovskiy issledovatel'skiy fizikoekhnicheskii institut, Gorkovskiy gosudarstvenniy universitet)

TITLE: Donor properties of nitrogen injected into silica and germanium by ion bombardment 27 27.55 21.44.55

SOURCE: AN SSSR. Doklady, v. 163, no. 5, 1965, 1128-1130

TOPIC TAGS: ionizing radiation, nitrogen, argon, ion current, ion density, silica, crystal structure

ABSTRACT: The silica plate samples, having a resistivity of 1 ohm.cm., were cut

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L 15977-66

ACC NR: AP5021276

perpendicular to the crystallographic direction  $[111]$ , polished mechanically and chemically to a microscopically smooth surface, and subjected to bombardment by atomic nitrogen ions in an accelerator with magnetic analyzer at an energy of 57 kev. The density of the ion current was  $\leq 4$  amp./sq.cm. and the vacuum near the target was  $\sim 10^{-5}$  mm.Hg. After irradiation the samples were annealed at various temperatures in a  $10^{-5}$  mm. Hg. vacuum. The n-type layer was formed on irradiated silica surfaces (at the dose range of 50 - 5000 coulomb/sq.cm.) after short annealing (1-3 minutes) at temperatures  $\geq 700^{\circ}\text{C}$ , whereas the inversion layer was not observed even after an annealing for 4 hours at temperatures  $\geq 500^{\circ}\text{C}$ . The fact that inversion layers were formed only after annealing at sufficiently high temperatures indicated that their generation was affected by the donor properties of the nitrogen. The bombardment of silica plates with argon ions did not result in the formation of inversion layers after subsequent annealing at various temperatures. The bombardment of p-type germanium ( $\rho = 1$  ohm.cm.) by nitrogen ions resulted in the formation of n-layers at doses  $> 1000$

ACC NR: AP5021276

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L 15977-66

ACC NR: AP5021276

ccoulomb/sq.cm. after prolonged annealing at 450C. The annealing at lower temperatures was evidently insufficient for removal of radiation defects. The thermoconversion occurred at temperatures  $\geq 500C$ . Orig. art. has: 1 figure.

SUB CODE: 20 SUBM DATE: 06Jun65/ ORIG REF: 001/ OTH REF: 006

Card 3/39

I 22918-66  
 ACC NR: AP6009655  
 EMP(e)/EMP(m)/EMP(t) IJP(c) JD  
 SOURCE CODE: UR/0181/66/008/003/0750/0752  
 AUTHORS: Pavlov, P. V.; Zorin, Ye. I.; Tetel'sbaum, D. I.  
 ORG: Gor'skiy State University im. N. I. Lobachevskiy (Gor'kovskiy gosudarstvennyy universitet)  
 TITLE: Characteristics of photodiode obtained by bombarding silicon with boron ions  
 SOURCE: Fizika tverdogo tela, v. 8, no. 3, 1966, 750-752  
 TOPIC TAGS: silicon, ion bombardment, photodiode, pn junction, boron, photosensitivity, spectral energy distribution  
 ABSTRACT: In view of some contradictions in the published data on the production of photoelectric p-n junctions by ion bombardment, the authors investigated the dependence of the characteristics of photodiodes obtained by bombarding n-silicon with 60-keV boron ions on the irradiation dose and on the annealing temperature. The n-type silicon was doped with phosphorus and was externally oxidized to an oxide thickness of 0.7  $\mu$ . Windows of 500  $\mu$  diameter were etched on the

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I 22918-66

ACC NR: AP6009655

oxide surface by photolithography. A second oxidation covered the windows with a layer of  $\text{SiO}_2$  of  $0.2 \mu$  thickness. The bombardment with 68-kev boron ions was in an accelerator with a magnetic analyzer. The irradiation doses were 0.1, 10, 100, 300, 500, and  $700 \mu\text{C}/\text{cm}^2$ . The annealing temperature varied from 600 to 1,000C and the annealing time from 3 to 30 minutes. At  $0.1 \mu\text{C}/\text{cm}^2$  the diodes had very poor photo-response at all annealing temperatures. At doses above  $100 \mu\text{C}/\text{cm}^2$  the photosensitivity decreased. Removal of layers of different thicknesses has shown that the dislocations penetrate to a depth of approximately  $1 \mu$ , whereas the p-n junction lies  $0.5 \mu$  thick, so that the dislocations can participate in the excess carrier recombination on both sides of the junction. The dependence of the photocharacteristics on the annealing temperature is attributed to the fact that with increasing dose a high temperature is necessary to anneal out the defects that influence the conductivity of the inversion layer. A preliminary investigation of the spectral characteristics of the photodiodes has shown that their maximum sensitivity is at  $0.85 - 1.1 \mu$  wavelength, and that this maximum shifts towards longer wavelengths with increasing

Card 2/3

Card 3/3

ACC NR: AR601891

SOURCE CODE: UR/01B1/66/008/006/1791/1795

AUTHOR: Pavlov, P. V.; Zorin, Ye. I.; Tetel'baum, D. I.ORG: Gor'kiy State University in. N. I. Lobachevskiy (Gor'kovskiy gosudarstvennyy universitet)TITLE: Inversion layers produced on n-type germanium bombarded with boron and aluminum ions

SOURCE: Fizika tverdogo tela, v. 8, no. 6, 1966, 1791-1795

TOPIC TAGS: germanium semiconductor, surface property, ion bombardment, boron, aluminum, impurity conductivity

ABSTRACT: To check whether the inversion layer produced on the surface of germanium by ion bombardment depends on the type of ion used, the authors bombarded germanium with 50-kev ions of several elements (B, Al, Ne, Ar, C). The irradiation procedure was described before (FTT v. 6, 3222, 1964). The ion current was  $\sim 5 \mu\text{A}/\text{cm}^2$  and the dose ranged from 0.01 to 1000 Coul/cm<sup>2</sup>. The presence of the inversion layer was determined by a procedure described in the earlier paper, and the resistivity of the inversion layer was measured both directly after irradiation and after annealing; in the latter case the dependence on the annealing temperature was also measured. In addition, a study was made of the depth distribution of the acceptors (Al and B) introduced by ion bombardment. The results show clearly that the surface resistance depends in a complicated manner on the type of bombarding ion, the irradiation dose,

Card 1/2



ACC NR: AP6033559

SOURCE CODE: UR/0181/66/008/010/2977/2981

AUTHOR: Pavlov, P. V.; Uskov, V. A.

ORG: Gor'kiy State University im. N. I. Lobachevskiy (Gor'kovskiy gosudarstvennyy universitet)

TITLE: Investigation of the diffusion of antimony and indium in germanium with account of the internal electric field

SOURCE: Fizika tverdogo tela, v. 8, no. 10, 1966, 2977-2981

TOPIC TAGS: antimony, indium, germanium, physical diffusion, semiconductor research, gamma spectrum, surface property, crystal lattice defect

ABSTRACT: This is a continuation of earlier work (PTT v. 7, 3346, 1965), where a theoretical analysis was made of the influence of the internal electric field on the diffusion of impurities in intrinsic and impurity semiconductors. The present investigation was an experimental check on the results, as applied to the diffusion of antimony and indium in n-type germanium. The diffusing atoms were the isotopes  $Sb^{124}$  and  $In^{114}$  from the gas phase, under conditions corresponding to a constant source. The depth variation of the impurity concentration was determined by the method of layer removal. The residual activity of the sample was measured with a scintillation  $\gamma$  spectrometer. The procedure for determining the diffusion coefficients is described in a paper by V. Ye. Kosenko (Izv. AN SSSR, ser. fiz. v. 20, 1526, 1956), by comparison of the experimental curves with the standard curves derived in the authors' earlier

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ACC NR: AP6033559

paper. The diffusion coefficients and the various diffusion parameters are tabulated. The results confirm the correctness of the formula derived in the earlier paper for the distribution of the impurity with allowance for the internal electric field arising during the impurity diffusion process, provided the surface concentration does not exceed  $4 \times 10^{19} \text{ cm}^{-3}$ . When the concentration increases, certain factors unaccounted for in the earlier paper come into play. One of them is the occurrence of the defects in the lattice during the impurity diffusion. Another may be the presence of both neutral and ionized atoms in the diffusion flow. The experimental evidence favors the assumption that the deviation from the theoretical values are due to the formation of lattice defects. Orig. art. has: 2 figures, 1 formula, and 3 tables.

SUB CODE: 20/    SUBM DATE: 14Dec65/    ORIG REF: 003/    OTH REF: 014

Card 2/2

ACC NR: AF6033567

SOURCE CODE: UR/0181/66/008/010/3043/3046

AUTHOR: Pavlov, P. V.; Sterkhov, V. A.

ORG: Gor'kiy State University im. N. I. Lobachevskiy (Gor'kovskiy gosudarstvenny universitet)

TITLE: Diffusion of indium over the surface of germanium

SOURCE: Fizika tverdogo tela, v. 8, no. 10, 1966, 3043-3046

TOPIC TAGS: indium, germanium, metal diffusion, surface property, transport property

ABSTRACT: The authors report results of an investigation of the diffusion and electric transport of indium over the (111) surface of single-crystal p-type Ge with resistivity 1 ohm-cm and dislocation density  $3 \times 10^3 \text{ cm}^{-2}$ . The diffusion was carried out at 600 - 910C, and the electric transport at 500 - 800C. The distribution of the diffusing atoms in depth was determined by a "layered sample" method, using  $\text{In}^{114}$  as the tracer, wherein the sample was made up of stacks of 8 - 10 plates  $5 \times 5 \times 0.4 \text{ mm}$ , and the activities of the different surfaces were measured. The experimental data obtained on the diffusion was reduced by the "standard-curves" method described by one of the authors earlier (Pavlov, with V. A. Panteleyev, FTT v. 7, 2209, 1965). Account was taken of the fact that indium is transported by the electric field either to the anode or to the cathode, depending on the temperature, owing to different degrees of electron-hole dragging. The values obtained for the coefficient of surface diffusion,  $D_1 = 2 \times 10^2 \exp(-54.5/RT) \text{ cm}^2/\text{sec}$ , agree well with the results obtained by others. The

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ACC NR: AF6033567

authors thank V. A. Panteleyev and V. A. Uskov for a useful discussion. Orig. art.  
has: 3 figures and 10 formulas.

SUB CODE: 20/      SUBM DATE: 07Feb66/      ORIG REF: 013/      OTH REF: 004

Card 2/2

ACC NR: AP7007168

SOURCE CODE: UR/0070/67/012/001/0155/0157

AUTHOR: Pavlov, P. V.; Tetel'baum, D. I.; Zorin, Ye. I.; Kudryavtseva, R. V.

ORG: Gor'kiy Physicotechnical Research Institute (Gor'kovskiy issledovatel'skiy fiziko-tekhnicheskiy institut)

TITLE: The amorphism in polycrystalline germanium films resulting from irradiation with argon ions

SOURCE: Kristallografiya, v. 12, no. 1, 1967, 155-157

TOPIC TAGS: amorphous polymer, semiconducting film, polycrystalline film, germanium semiconductor, thin film semiconductor, irradiation effect, argon, ion

ABSTRACT: An investigation was made of the transition of crystalline germanium into the amorphous state as the result of irradiation. The experiment was performed with thin polycrystalline germanium films. The films were obtained by the vacuum coating of an NaCl backing heated to 400°C. The film thickness varied from 200 to 500 Å, which meant that it was smaller than the mean free path of the ions. Bombardment with 5-keV argon ions was performed in an accelerator with a magnetic analyzer. The density of the ion current was 2 to 4  $\mu\text{amp}/\text{cm}^2$ . The irradiation doses were 1, 10, 100, 1000, and 5000  $\mu\text{curie}/\text{cm}^2$ . The vacuum in the

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UDC: 548.74

ACC NR:AP7007168

-5

vicinity of the target was  $2 \times 10^{-5}$  mm Hg. During bombardment, the specimens were heated to  $90^{\circ}\text{C}$  in order to reduce organic vapors. At a dose of  $1 \mu\text{curie}/\text{cm}^2$  no changes were observed in the specimens. However, at doses of  $10 \mu\text{curie}/\text{cm}^2$  and larger, the electronograms clearly indicated the transformation of the germanium into the amorphous state: the sharp lines disappeared and were replaced by two or three diffusion rings. The location of the intensity maxima did not coincide with the location of the interference rings of the crystalline germanium, except for the first maximum, which was located at the position of the (111) line. This showed that the structure obtained was not microcrystalline, but amorphous. Two basic mechanisms of amorphism are proposed. First, a gradual accumulation of Frenkel defects during irradiation can lead to the displacement of atoms to new positions and, consequently, to the disruption of proper order. The second mechanism consists in the generation of regions of local fusion (thermal peaks) inside the germanium by means of retarded ions. These peaks harden in a short time

-11 -12

(10 - 10 sec). Crystallization cannot occur in such a short time. As a result, a liquid structure or some intermediate state (partial crystallization) appears. The first mechanism is considered more probable. Orig. art. has: 1 table.

SUB CODE: 20/ SUBM DATE: none/ ORIG REF: 004/ OTH REF: 011 [WA-95]  
[JA]

Card 2/2

PAVLOV, P.V.; LEONOVA, A.G.; SMIRNOV, M.V.

Effect of products of deep splitting of proteins in a culture medium on *C. diphtheriae* toxin formation. Report No.1: Medium digested by an enzymatic mixture of trypsin and enterokinase for the preparation of diphtherial toxin. Zhur.mikrobiol.epid.i immun. 31 no.8:65-69 Ag '60. (MIRA 14:6)

1. Iz Otdela profilaktiki detskikh infektsiy Instituta epidemiologii i mikrobiologii imeni Gamalei AMN SSSR.  
(CORYNEBACTERIUM DIPHTHERIAE) (TOXINS AND ANTITOXINS)  
(BACTERIOLOGY—CULTURES AND CULTURE MEDIA)  
(TRYPSIN) (KINASE)

SEMENOVA, I.P.; RUBANOVICH, G.I.; PAVLOV, R.K.

Surgery in knife wounds of the heart performed under conditions of clinical death. Vest.khir. 86 no.3:115-116 Mr '61.

(MIRA 14:3)

1. Iz fakul'tetskoy khirurgicheskoy kliniki (zav. - prof. S.L. Libov) Kuybyshevskogo meditsinskogo instituta. Adres avtorov: Kuybyshev (obl.) Semeykenskoye shosse, klinicheskaya bol'nitsa, fakul'tetskaya khirurgicheskaya klinika.

(HEART—WOUNDS AND INJURIES) (RESUSCITATION)



PAVLOV, P.V.

The Savala Forestry; climatic and silvicultural characteristics and  
the history of the establishment of cultivated forest stands. Trudy  
VIZR no.15:13-32 '60. (MIRA 14:3)  
(Voronezh Province--Forests and forestry)

AVL, I. . . . .

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PAVLOV, P.V.

DECEASED  
C: 1961

1962/4

SEE IIC

AGRIC MACHINERY

PAVLOV, P. Z.

Structure and spatial distribution of metals in the Løbnitsa lead and zinc deposits, Kyustendil District. Spis Bulg geol druzh 25 no.3:239-244 '64.

1. Gyueshevo Mine, Kyustendil District. Submitted April 17, 1963.

MITREVA, Nedelia; PAVLOV, Pavel K.

Influence of ammonium nitrate and superphosphates on the  
germination of millet. Selskoston nauka [2] no. 2: 250-251  
'63.

PAVLOV, P.V., aspirant

Determining the accuracy of stream leveling for the calculation  
of the Chezy coefficient. Izv. vys. ucheb. zav.; geod. i aerof.  
no.2:69-76 '61. (MIRA 14:6)

1. Kiyevskiy inzhenerno-stroitel'nyy institut.  
(Leveling) (Hydrographic surveying)

L 22510-66 ENT(1)/ENT(m)/T/ENT(t) IJP(c) JD/GG

ACC NR: AP6009650

SOURCE CODE: UR/0181/66/008/003/0725/0730

AUTHOR: Pavlov, P. V.; Layner, L. V.; Sterkhov, V. A.; Panteleyev, V. A. 48

ORG: Gor'kiy State University im. N. I. Lobachevskiy (Gor'kovskiy gosudarstvennyy universitet) 13

TITLE: On the proof of the existence of an autonomous diffusion flux along isolated dislocations 4

SOURCE: Fizika tverdogo tela, v. 8, no. 3, 1966, 725-730

TOPIC TAGS: crystal lattice dislocation, physical diffusion, silicon, single crystal

ABSTRACT: This is a continuation of earlier work by the authors (FIT v. 7, 922, 1965 and v. 6, 384, 1964), where it was shown that diffusion along dislocations exist in single crystals of germanium and silicon, in addition to the ordinary volume diffusion. Since these results differ from those of many others, the authors present, using the diffusion of indium in silicon as an example, new results to confirm that the diffusion along the dislocations is much faster than through the volume. The investigations were made on "sitting" dislocations. p-type silicon samples were used, with specific resistivity 18 ohm-cm and average dislocation density  $N_d = 10^4 \text{ cm}^{-2}$ . The samples were cut from a specially grown

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L 22540-66

ACC NR: AF6009650

ingot, which contained dislocations of only one kind, "sitting" dislocations parallel strictly to the growth axis [110]. The diffusing indium was tagged with  $\text{In}^{114}$ . The diffusion from the gas phase in quartz ampoules is accurate to  $10^{-4}$  torr at temperatures 1010--1270C. The distribution of the indium was determined by removal of layers. In parallel with this method, autoradiographic study of the diffusion was also made to exclude the possibility of simultaneous existence of other diffusion mechanisms. The data yielded for the diffusion coefficient and diffusion heat along the dislocations values of  $10^4 \text{ cm}^2/\text{sec}$  and 77 kcal/mole, respectively, as against  $16.5 \text{ cm}^2/\text{sec}$  and 90 kcal/mole for volume diffusion. A criterion is introduced, making it possible to estimate the influence of volume diffusion on the form of the concentration curve, and it is shown that the diffusion actually observed takes place along the dislocations and cannot be attributed to the settling of indium on the dislocations when the sample is cooled. The dimension of the effective diffusion region around the dislocations is determined by an independent electron transport method, and is found to be of the order of 100 Å. Orig. art. has: 3 figures, 11 formulas, and 1 table.

SUB CODE: 20/    SUBM DATE: 16Jul65/    ORIG REF: 012/    OTH REF: 005

Card 2/2 BK



KUDREV, Todor; PAVLOV, Petur

Influence of the drying up of swollen and germinated seeds  
and plants in the fall on the development and yield of the  
wheat. Selskostop nauka 2 no.1:117-123 '63.

VOL'SKAYA, L., inzh.; PAVLOV, R., inzh.; SHCHERBAKOV, V., inzh.

Standard series of automatic equipment for refrigerating machines  
[with summary in English]. Khol. tekhn. 35 no.4:39-44 J1-Ag '58.  
(MIRA 11:10)

1. Tsentral'noye konstruktorskoye byuro kholodil'nogo mashinostroyeniya.  
(Refrigeration and refrigerating machinery)

1 47340-65 EN 1)/EWI(a)/I/EWP(t)/ETI IJP(c) JD

ACC NR: AR6025735

SOURCE CODE: UR/0058/66/000/004/A075/A075

AUTHOR: Rarenko, I. M.; Pankevich, Z. V.; Pavlov, R. A.; Semizorov, A. P.

TITLE: Development of operating conditions and apparatus for the synthesis and growing of single crystals of  $A^{II}B^V$  compounds, using physico-chemical analysis

SOURCE: Ref. zh. Fizika, Abs. 4A627

REF SOURCE: Sb. Simpozium. Protsessy sinteza i rosta kristallov i plenok poluprovodnik. materialov, 1965. Tezisy dokl. Novosibirsk, 1965, 32-34

TOPIC TAGS: single crystal growing, zinc compound, cadmium compound, antimonide, stoichiometry

ABSTRACT: The possibility of obtaining single crystals of  $CdSb$  and  $ZnSb$  was investigated. Single crystal p- and n-type  $CdSb$  with a carrier density  $\sim 1 \times 10^{14} \text{ cm}^{-3}$  at 77K was grown by the Czochralski method, using specially constructed apparatus, in various inert gases at pressures 0.1 - 3 kg/cm<sup>2</sup>. The temperature of the melt and of the space over the melt was maintained constant by separate thermal regulators accurate to  $\pm 0.05^\circ\text{C}$ . A physico-chemical analysis was made of alloys of the Cd-Sb system, with stoichiometric and near-stoichiometric composition, in the temperature interval up to 650C. Apparatus in which conditions could be created for obtaining single-phase crystals of compounds that melt non-congruently was constructed and used to grow  $ZnSb$  crystals. [Translation of abstract]

SUB CODE: 20

Card 1/1 pb

PAVLOV, R.K.

Two cases of Barre-Mason disease. Kaz.med.zhur. no.5:61-62  
S-0 '62. (MIRA 16:4)

1. Fakul'tetskaya khirurgicheskaya klinika (zav. - prof.  
S.L.Libov) Kuybyshevskogo meditsinskogo instituta.  
(ANGIOMA)

RUBANOVICH, G.L.; PAVLOV, R.K.

Use of the muscle relaxant, decamethonium (procuran). *Khirurgia*  
no.12:21-26 '61. (MIRA 15:11)

1. Iz kliniki fakul'tetskoy khirurgii (zav. - prof. S.L. Libov)  
Kyybyshevskogo meditsinskogo instituta.  
(CURARELIKE SUBSTANCES)

PHILIP M

**AUTHORS:** Burtsov, Y.M., Yelyutin, S.P., Zarayev, I.I., Lysenko, N.Ye.,  
Migdal, Ye.Ia., Molchanik, Yu.T., Mysina, A.S., Myagkov, M.A.,  
Favicy, B.M. and Filippovich, V.K. SOV/19-58-6-554/685

**TITLE:** A Method of Coloring the Ends of Paper Cartridges on Bobbin-  
Winding Machines (Sposob okraski kontsov bumaznykh patronov  
na shpulezavertochnykh mashinakh)

**PERIODICAL:** Byulleten' izobreteniy, 1958, Nr 6, p 122 (USSR)

**ABSTRACT:** Class 54c, 4. Nr 113596 (580171 of 11 Oct 57). Submitted to  
the Committee for Inventions and Discoveries at the Ministers  
Council of USSR. In order to simultaneously color both ends  
of the cartridge by one coloring roller, the paint is applied  
on one side of the paper tape in the form of rectangular sections;  
the tape is cut down the center of the colored sections  
and fed to the rotating spindle with the side opposite to  
the colored sections facing outwards.

Card 1/1

SINYAGIN, I.I., red.; MOVSISYANTS, A.P., otv. za vypusk; NIKOLAYEVA, G.F., red.; PAVLOV, R.P., red.; POTOTSKAYA, N.M., tekhn. red.

[Farm management system in Novosibirsk Province; materials of the outsession of the Lenin All-Union Academy of Agricultural Sciences, Novosibirsk, July 29th - August 2nd, 1958] O sisteme vedenia sel'skogo khoziaistva v Novosibirskoi oblasti; materialy vyezdnoi sessii Akademii 29 iulia - 2 avgusta 1958 goda g. Novosibirsk. Novosibirskoe knizhnoe izd-vo. Vol.3. 1959. 401 p. (MIRA 14:8)

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(Novosibirsk Province--Agriculture)

SINYAGIN, I.I., red.; NOVSISIYANTS, A.P., otv. za vypusk; NIKOLAYEVA,  
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chlen-korrespondent Vsesoyuznoy akademii sel'skokhozyaystvennykh  
nauk imeni V.I.Lenina (for Sinyagin).  
(Novosibirsk Province--Agriculture)



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Paulov R. V.

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Special Colloquy of ICR (Collected Soviet Reports) Moscow, Gostorgizdat, 1959. 218 p. Errata slip inserted. 2,000 copies printed.  
Ed. (This page): Sh. S. Eshelabril; Ed. (Inside book): E. V. Chikobov; Mos. M.: V. V. Babitskaya.

FOREWORD: This collection of articles is intended for those interested in the problems of food refrigeration.  
CONTENTS: The collection contains 26 reports which were submitted at the meeting of the 3rd, 4th, and 5th Congresses of the International Institute of Refrigeration. The meeting was held in Moscow, U.S.S.R., from July 1958, and was attended by 255 Soviet specialists and 115 representatives from 27 other countries. The 75 reports discussed at this meeting cover such broad areas as the automation of the cooling of refrigerating installations, the use of flame-tube type refrigerating devices, heat-freezing food freezers, the theory and technique of rapid cooling and freezing of meat and fish, the use of antibiotics in the cold storage of food, and the operation of refrigerators and cooling systems. A complete account of the proceedings of this meeting was published by the International Institute of Refrigeration in 1959. No personalities are mentioned. References follow several of the articles.

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